

Notice of References Cited

Application/Control No.

10/720,110

Applicant(s)/Patent Under

Reexamination

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Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,064,756	05-2000	Beaty et al.	382/146
*	B	US-7,027,963	04-2006	Watanabe et al.	703/1
*	C	US-6,173,070	01-2001	Michael et al.	382/145
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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